

<Intelligent Power Modules>

PM300CG1C065

FLAT-BASE TYPE INSULATED PACKAGE

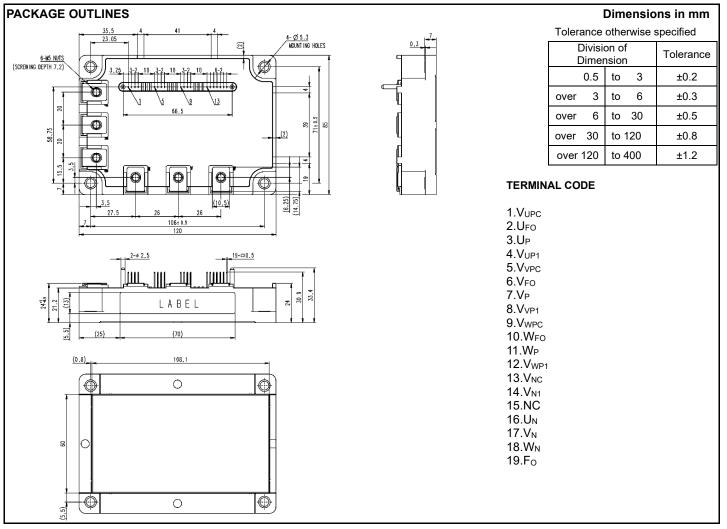
## FEATURE

- a) Adopting Full-Gate CSTBT<sup>™</sup> chip.
- b) The over-temperature protection which detects the chip surface temperature of CSTBT<sup>™</sup> is adopted.
- c) Error output signal is available from each protection upper and lower arm of IPM.
- d) Outputting an error signal corresponding to the abnormal state (error mode identification)

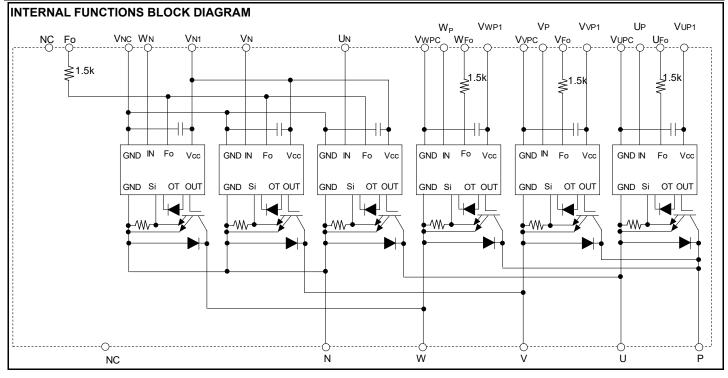
UL Recognized under UL1557, File No. E323585 This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU)2015/863.

## APPLICATION

General purpose inverter, servo drives and other motor controls



# <Intelligent Power Modules> PM300CG1C065 HIGH POWER SWITCHING USE INSULATED TYPE



MAXIMUM RATINGS (Tvj = 25°C, unless otherwise noted)

#### **INVERTER PART**

Symbol	Parameter	Conditions	Ratings	Unit
V <sub>CES</sub>	Collector-Emitter Voltage	V <sub>D</sub> =15 V, V <sub>CIN</sub> =15 V	650	V
lc	Collector Current	T <sub>c</sub> =25 °C	300	•
I <sub>CRM</sub>	Collector Current	Pulse	600	A
P <sub>tot</sub>	Total Power Dissipation	T <sub>c</sub> =25 °C	1041	W
I <sub>E</sub>	Emitter Current	T <sub>c</sub> =25 °C	300	
I <sub>ERM</sub>	(Free-wheeling Diode Forward current)	Pulse	600	A
Tvj	Junction Temperature	(Note5)	-20 ~ +150	°C

\*: Tc measurement point is just under the chip.

#### **CONTROL PART**

Symbol	Parameter	Conditions	Ratings	Unit
V <sub>D</sub>	Supply Voltage	Applied between: $V_{UP1}$ - $V_{UPC}$ , $V_{VP1}$ - $V_{VPC}$ , $V_{WP1}$ - $V_{WPC}$ , $V_{N1}$ - $V_{NC}$	20	V
V <sub>CIN</sub>	Input Voltage	Applied between: $U_P$ - $V_{UPC}$ , $V_P$ - $V_{VPC}$ , $W_P$ - $V_{WPC}$ , $U_N$ , $V_N$ , $W_N$ - $V_{NC}$	20	V
V <sub>FO</sub>	Fault Output Supply Voltage	Applied between: U <sub>FO</sub> -V <sub>UPC</sub> , V <sub>FO</sub> -V <sub>VPC</sub> , W <sub>FO</sub> -V <sub>WPC</sub> , Fo-V <sub>NC</sub>	20	V
I <sub>FO</sub>	Fault Output Current	Sink current at $U_{FO}$ , $V_{FO}$ , $W_{FO}$ , Fo terminals	20	mA

### TOTAL SYSTEM

Symbol	Parameter	Conditions	Ratings	Unit
V <sub>CC(PROT)</sub>	Supply Voltage Protected by SC	V <sub>D</sub> =13.5 V~16.5 V, Inverter Part, Tvj=+125°C start	400	V
T <sub>stg</sub>	Storage Temperature	-	-40 ~ +125	°C
Tc	Operating Case Temperature	(Note5)	-20 ~ +125	°C
V <sub>isol</sub>	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base plate, AC 1min, RMS	2500	V

\*: Tc measurement point is just under the chip.

## THERMAL RESISTANCE

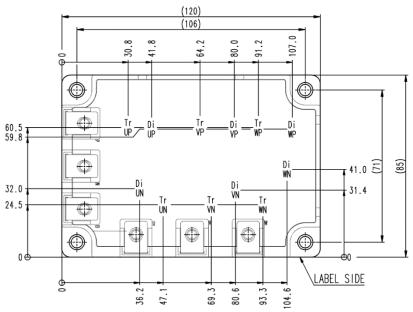
Symbol Parameter	Devenueter	O constitutions of	Limits			1.1
	Palameter	Conditions		Тур.	Max.	Unit
$R_{th(j-c)Q}$	Thermal Resistance	Junction to case, IGBT, per 1 element (Note1)	-	-	0.12	K/W
$R_{th(j-c)D}$		Junction to case, FWD, per 1 element (Note1)	-	-	0.19	
$R_{th(c-s)}$	Contact Thermal Resistance	Case to heat sink, per 1 module,		8.4	-	K/kW
		Thermal grease applied (Note.1, 2, 5)	-	0.4		IVKVV

Note1. If you use this value,  $R_{th(s-a)}$  should be measured just under the chips.

Note2. Typical value is by thermally conductive grease of  $\lambda$ =0.9W/(m·K), D<sub>(C-S)</sub>=50 µm.

#### CHIP LOCATION (Top view)

Dimension in mm, torelance:  $\pm 1$ mm



Tr**	: IGBT	
Di**	: FWD	

## ELECTRICAL CHARACTERISTICS (Tvj= 25°C, unless otherwise noted)

#### INVERTER PART

Symbol	Deremeter	Conditions			Limits		Unit	
Symbol	Parameter	Conditio	ns		Min.	Тур.	Max.	Onit
V <sub>CEsat</sub> Collector-Emitter Saturation Voltage		V <sub>D</sub> =15 V, I <sub>C</sub> =300 A Tvj=25 °C	Terminal	-	-	2.05		
			TVJ=25 C	Chip	-	1.25	-	v
	(-0)/Dulad (Fig. 1)	Tvj=125 °C	Terminal	-	-	2.30	v	
		V <sub>CIN</sub> =0 V, Pulsed, (Fig.1)	IVJ=125 C	Chip	-	1.33	-	
		V <sub>D</sub> =15 V, I <sub>F</sub> =300 A, Tvj=25 °	Tui-25 °C	Terminal	-	-	2.1	
	V <sub>D</sub> -13 V, I <sub>E</sub> -300 A,	Tvj=25 °C	Chip	-	1.40	-	v	
V <sub>EC</sub>	Emitter-Collector Voltage	V <sub>CIN</sub> = 15 V, pulsed, (Fig.2) Tvj=125 °C	Tui-125 °C	Terminal	-	-	2.2	v
			Chip	-	1.45	-		
t <sub>on</sub>		V <sub>D</sub> =15 V, V <sub>CIN</sub> =0 V↔15 V,			0.3	0.6	1.2	
t <sub>rr</sub>		V <sub>cc</sub> =300 V, I <sub>c</sub> =300A,		-	0.2	0.65		
t <sub>c(on)</sub>	Switching Time	Tvj=125 °C,			-	0.2	0.75	μs
t <sub>off</sub>		Inductive Load			-	1.1	2.3	
t <sub>c(off)</sub>		(Fig.3, 4)			-	0.16	0.4	
		V <sub>CE</sub> =V <sub>CES</sub> , V <sub>D</sub> =15 V,		Tvj=25 °C	-	-	1	
I <sub>CES</sub>		lector-Emitter Cut-off Current $V_{CIN}^{CEV}$ (Fig.5)		Tvj=125 °C	-	-	10	mA

### ELECTRICAL CHARACTERISTICS (Tvj = 25°C, unless otherwise noted)

CONTROL PART

Currente e l	Parameter	Conditions			Limits		Unit	
Symbol	Falameter	Conditions		Min.	Тур.	Max.	Unit	
			V <sub>P1</sub> -V <sub>PC</sub>	-	4	6		
	Cincuit Current	V <sub>D</sub> =15 V, V <sub>CIN</sub> =15 V	V <sub>N1</sub> -V <sub>NC</sub>	-	12	18		
ID	Circuit Current	$V_D$ =15 V, $V_{CIN}$ =0 V $\leftrightarrow$ 15 V, $V_{CC}$ =400 V	V <sub>P1</sub> -V <sub>PC</sub>	-	36	44	mA	
		l <sub>c</sub> =0A, Tvj=125 °C, f <sub>c</sub> ≤20kHz	V <sub>N1</sub> -V <sub>NC</sub>	-	109	131		
V <sub>th(ON)</sub>	Input ON Threshold Voltage	Applied between: UP-VUPC, VP-VVPC, WP-VWPC, UN, VN, WN-VNC		1.2	1.5	1.8	v	
$V_{th(OFF)}$	Input OFF Threshold Voltage			1.7	2.0	2.3	v	
SC	Short Circuit Trip Level	-20≤Tvj≤125 °C, V <sub>D</sub> =15 V (Fig.3, 6)		600	-	-	А	
t <sub>d(SC)</sub>	Short Circuit Current Delay Time	V <sub>D</sub> =15 V, Tvj=125 °C (Fig.3, 6)		-	2.0	-	μs	
ОТ		emperature Protection Detect temperature of IGBT chip surface	Trip level	Trip level	150	-	-	- °C
OT <sub>(hys)</sub>	Over temperature Protection		Hysteresis	-	20	-		
UVt	Supply Circuit		Trip level	11.0	12.0	12.7	v	
UVr	Under-Voltage Protection	-	Reset level	-	12.5	-	v	
I <sub>FO(H)</sub>				-	-	0.01		
I <sub>FO(L)</sub>	Fault Output Current	V <sub>D</sub> =15 V, V <sub>FO</sub> =15 V (Note3)		-	10	15	mA	
			OT	-	8.0	-		
t <sub>FO</sub>	Fault Output Pulse Width	V <sub>D</sub> =15 V (Note3)	UV	-	4.0	-	ms	
			SC	-	2.0	-		

Note3. Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

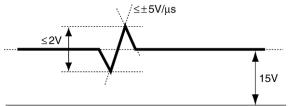
#### MECHANICAL RATINGS AND CHARACTERISTICS

Symbol	Parameter	Conditions		Limits		
Symbol	Falance			Тур.	Max.	Unit
Ms	Mounting Torque	Mounting part screw : M5	2.5	3.0	3.5	N•m
Mt	Mounting Torque	Main terminal part screw : M5	2.5	3.0	3.5	IN•III
m	mass	-	-	425	-	g

RECOMME	NDED CONDITIONS FOR USE

Symbol	Parameter	Conditions	Recommended value	Unit
V <sub>cc</sub>	Supply Voltage	Applied across P-N terminals	≤ 400	V
V <sub>D</sub>	Control Supply Voltage	Applied between : V <sub>UP1</sub> -V <sub>UPC</sub> , V <sub>VP1</sub> -V <sub>VPC</sub> , V <sub>WP1</sub> -V <sub>WPC</sub> , V <sub>N1</sub> -V <sub>NC</sub> (Note4)	15.0±1.5	V
V <sub>CIN(ON)</sub>	Input ON Voltage	Applied between :	≤ 0.8	v
V <sub>CIN(OFF)</sub>	Input OFF Voltage	$U_{P}-V_{UPC}, V_{P}-V_{VPC}, W_{P}-V_{WPC}, U_{N}, V_{N}, W_{N}-V_{NC}$	≥ 9.0	V
f <sub>PWM</sub>	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
t <sub>dead</sub>	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig.7)	≥ 2.0	μs

Note4. With ripple satisfying the following conditions: dv/dt swing  $\leq \pm 5$  V/µs, Variation  $\leq 2$  V peak to peak



GND

Note5. Long term performance related to thermal conductive material such as thermal grease (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under your specific application conditions. Each temperature condition (Tvj, Tc) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

### **PRECAUTIONS FOR TESTING**

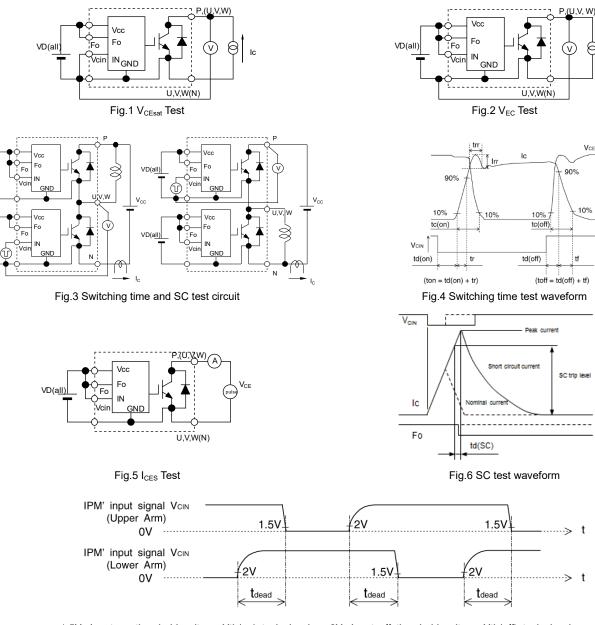
VD(all

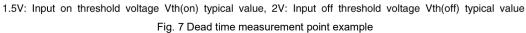
1. Before applying any control supply voltage (V<sub>D</sub>), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.

After this, the specified ON and OFF level setting for each input signal should be done.

2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above VCES rating of the device.

(These test should not be done by using a curve tracer or its equivalent.)



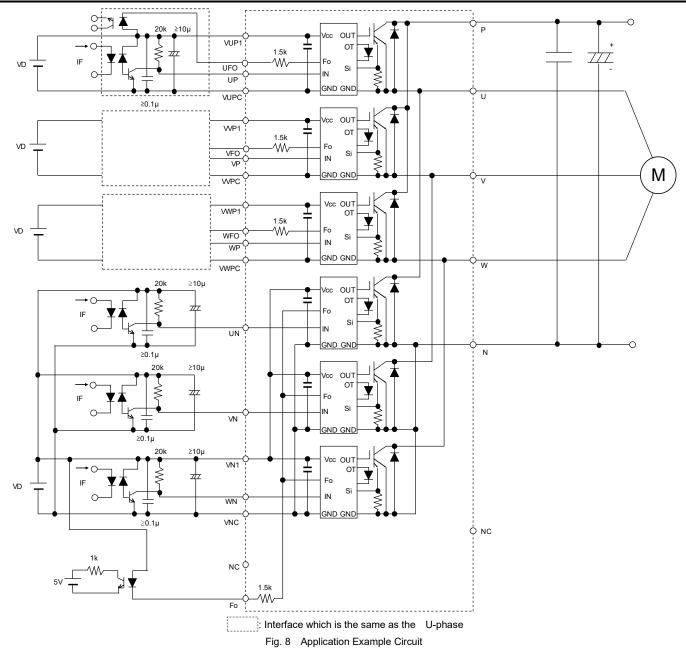


t

VCE

10%

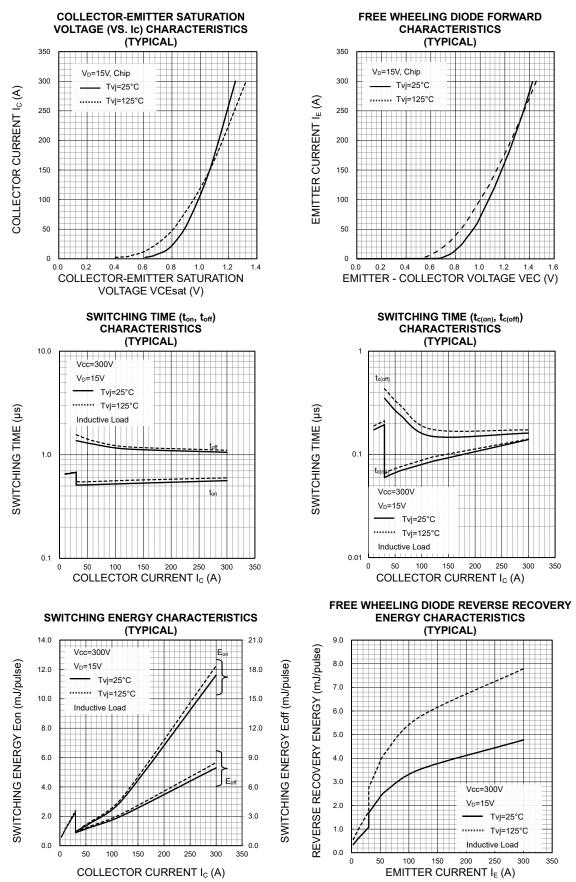
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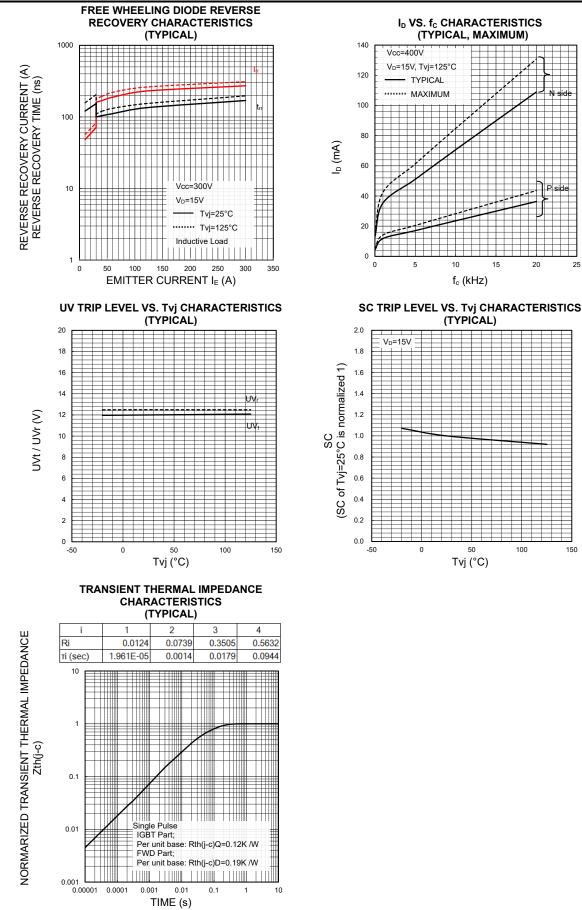
### NOTES FOR STABLE AND SAFE OPERATION ;

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers:  $t_{PLH}$ ,  $t_{PHL} \le 0.8 \mu s$ , Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- Use 4 isolated control power supplies (V<sub>D</sub>). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.

## PERFORMANCE CURVES



# <Intelligent Power Modules> PM300CG1C065 HIGH POWER SWITCHING USE INSULATED TYPE



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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